Product Specification

108-5826 SIM READER SLIDE TYPE WITH PEG

1 Scope :

1.1 Contents

This specification covers the requirements for product performance, test methods and quality assurance provisions of SIM READER SLIDETYPE WITH SOLDER PEG. The module is designed to make a connection between a Subscriber Identity Module (SIM) according to ISO 7816-2 and printed circuit board.

Applicable product description and part numbers are as shown in Appendix 1.

2. Applicable Documents:

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

- 2.1 AMP Specifications:
- A. 109-5000 Test Specification, General Requirements for Test Methods
- B. 501-5476 Qualification Test Report
- 2.2 Other Documents
- A. IEC 60512 Connectors used for frequencies below 3MHz
- B. IEC 60068 Basic environmental testing procedures for electric component and electronic equipment
- C. ISO7816-2 Identification Cards Integrated

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ON CONDITION THAT NO FURTHER C TO OTHER THAN AMP PERSONNEL V TION FROM AMP SHANGHAI LTD					Prepared by C.OHA Reviewed by I.ENOM	PE Manager	tyco Electronics	Tyco Electron AMP Shanghai	
NDITIO HER TH ROM A		Revises			Approved by T.MIYA	QA Manager ZAWA	^{NO} 108-5826	REV A2	ES
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3. Requirements:

3.1 Design and Construction :

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2 Materials :

Material used in the construction of this product shall be as specified on the applicable product drawing.

3.3 Ratings :

A. Voltage Rating: 15V MAX.

B. Current Rating:1.2A MAX. /contact

C. Operating Temperature: - 25 °C to 70 °C

D. Durability: 1500cycles

3.4 Performance Requirements and Test Descriptions :

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Fig. 1. All tests shall be performed in the room temperature, unless otherwise specified.

	-								
Para.	1	Test Items	Require	ments		Procedures			
3.5.1	Examin	nation of Product	Meets requirements of		of	Visual inspection No physical			
			product draw	ving.		damage			
						In acc. with IEC 60512-1 to	est 1a		
						Magnification 10X			
			Electrical I	Require	men	ts			
3.5.2	Contac	t Resistance	Initial: 50 m	Ω Max	ζ.	Subject mated contacts asso	embled	in	
	(Low Level)		Final: 100 m	Ω Ma	х.	housing to 20 mV Max ope	n circu	it	
	See para. 3.6.1					at 100 mA DC. See also pa	ra. 3.6.	1	
						In acc. with IEC 60512-2 test 2a			
3.5.3	Insulation Resistance		500 M Ω Min.			Impressed voltage 100 V DC.			
						Unmated card.			
						In acc. with IEC 60512-2 to	est 3a		
			Fig.1 (C	CONT.)					
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3.5 Test Requirements and Procedures Summary

D	m i t			I			
Para.	Test Items	Require			Procedures		
3.5.4	Voltage proof	No creeping		0	00VAC for 1 minute.		
		no flashover	shall		Jnmated card.		
		occur.		11	n acc. with IEC 60512-2 to	est 4a	
3.5.5	Electrical load and	Temperature	e at		Temperature at contact-point shall		
	Temperature	contact-poin		not n	ot exceed 70°C		
		exceed 70°C		C	Condition; 50°CMax. 1000	hrs	
				E	Electrical load; 0.8A		
				U	Jse Au-plated dummy care	d.	
				C	Card thickness; 0.76mm		
				Iı	n acc. With IEC 60512-5	Test 9b	
3.5.6	Current / Temperatur	e Temperature	limit at	t U	Under loaded specified cur	rent or	
	derating (Current	contact-poin	t shall n	not ra	ating current.		
	carrying capacity)	exceed 70°C		Iı	n acc. With IEC 60512-3	Test 5b	
		Mechanical			S		
3.5.7	Contact normal force				Normal force test equipme	nt	
		measured at	0.17mm	n (l	Force/ Deflection curve)		
		distance from	n housir	ng			
		top.					
		Requirement	t:0.3N				
		min. 0.7N m	ax.				
3.5.8	Vibration	No electrical	l		/ibration Frequency: 10-5	0Hz /	
	(Sinusoidal)	discontinuity	-		0.8mm , 60-500Hz / 6 G		
	See para. 3.6.2	than 1μ sec	cond sha		/ibration Direction: 3direc	ctions.	
		occur.			Duration: 2 hours each		
		No physical	damage	e. Ii	n acc. with IEC 60512-4 to	est 6d	
3.5.9	Mechanical Operatio	n 1 Sequence Te	est Grou	-	Operations shall be conduc	eted	
	See para. 3.6.2	1			nanual at 70°C dry heat		
				C	Operation cycles; 20		
				R	Rate; 10-cycle/1 minute.		
				R	Recovery time; 2 hrs		
				U	Jse Au-plated dummy care	d	
				C	Card thickness; 0.76mm		
				Iı	n acc. with IEC 60512-5 t	est 9a	
		Fig. 1 (CONT)				
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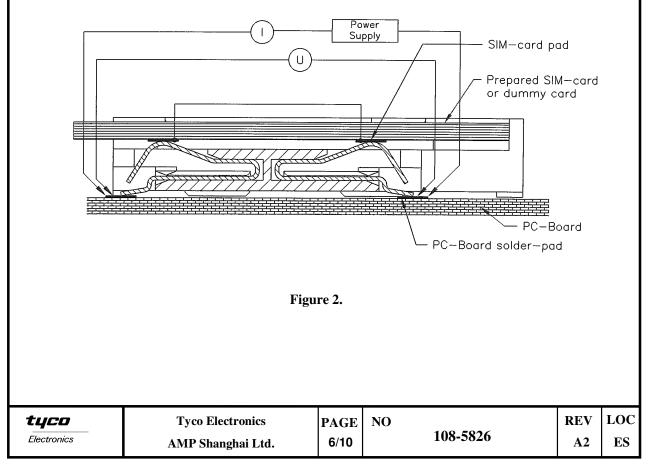
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Para.		Test Items	Require			Procedures		
3.5.10		nical Operation 2	Sequence Te	st Grou	ıp	Operations shall be conduc	ted	
	See pa	ra. 3.6.2	1			manual at -25°C dry heat		
						Operation cycles; 20		
						Rate; 10-cycle/1 minute.		
						Recovery time; 2 hrs		
						Use Au-plated dummy card	1	
						Card thickness; 0.76mm		
						In acc. with IEC 60512-5 to	est 9a	
3.5.11	Mecha	nical Operation 3	Sequence Te	st Grou	ıp	Test shall be conducted usi	ng real	
	See pa	ra. 3.6.2	2			cards.		
						Operation cycles; 750		
						Rate; 10-cycle/1 minute.		
						Speed; 10 mm/s		
						In acc. with IEC 60512-5 to	est 9a	
3.5.12	3.5.12 Physical Shock 1 No electrical				Slide 0.76mm thick dumm	y card i	n	
	See para. 3.6.2 discontinuity		greater	r	the connector. Subject test			
	than 1μ second		-		40G half sine shock pluses 6ms			
			occur.			duration.		
			No physical	damage		Endurance; 10shocks in bo	th	
			r j	0		directions of 3 mutual perp		lar
						axis.		
						In acc. with IEC 60512-4 to	est 6c	
3.5.13	Physic	al Shock 2	No physical	damage	<i>.</i>	Slide a real card of 0.76 ± 0).08mm	ı
	-	ra. 3.6.2	Card shall no	-		thick in the connector. Sub	ject test	t
	1		ejected.			frame to 500G half-sine sh	-	
			5			of 1 ms duration.	I	
						Endurance; 2 shocks in bot	h	
						directions of 3 mutual perp		ar
						axis.		
						In acc. with IEC 60512-4 t	est 6c	
			Environmenta	al Requi	irem		-	
3.5.14	Rapid	change of	Sequence Te	st Grou	ıp	−40°C / 60 min. , 85°C /6	0 min.	
	temper	•	1			Making this a cycle, repeat 5 cycles.		
	-					Recovery time 2 hours.		
						Use Au-plated dummy card	1.	
						Card thickness; 0.76mm		
						In acc, with IEC 60068-2-1	4	
			Fig.1 (C	CONT.)				
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Para.	Test Items	Requirem	ents	Procedures		
3.5.15	Dry heat 1	Sequence Test	t Group	70°C, Duration: 16 hrs.		
		1		Recovery time; 2 hours		
				Sample 1 and 2 unmated		
				Sample 3 and 4 mated:		
				Use Au-plated dummy card	d.	
				Card thickness; 0.76mm		
				In acc. with IEC 60512-6 T	Fest 11i	
3.5.16	Dry heat 2	Sequence Test	t Group	Temperature; 70°C, Durati	on: 100	0
		3		hrs.		
				Use Au-plated dummy card	d.	
				Card thickness; 0.76mm		
				In acc. with IEC 60512-5 T	Fest 9b	
3.5.17	Damp/heat steady state	e Sequence Test	t Group	Temperature; 40°C, R.H. 9	5 %	
		1		Duration: 21 days		
				In acc. with IEC 60512-5 7	Fest 11n	n
3.5.18	Cold	Sequence Test	t Group	Temperature; -25°C Durat	ion: 2 h	rs.
		1	I	Recovery time; 2 hours		
				Use Au-plated dummy card	d.	
				Card thickness; 0.76mm		
				In acc. with IEC 60512-5 T	Fest 11i	
3.5.19	Solderability	Wet Solder C	Coverage			
010117	Schuchart	is 95% Min.	00101080	Immersion Duration:		
		15 95 /0 101111.		3 ± 0.3 seconds		
				Ageing: 16 hrs at 155°C		
				In acc. with IEC 60068-2-2	20 test 7	Га
3.5.20	Resistance to Solderin	g No physical da	amage	2 cycles of heat curve cove		
5.5.20	Heat	shall occur.	unnuge	soldering curve specified in	-	
	See para. 3.6.3	(Cracks, chips	or	figure 4.	u .	
	500 pulu. 5.0.5	melting)	01	In acc. with EIA-J RX-010	2/102	
		moning)		para 3.3.4.	2/102	
				partolori		
		Fig. 1 (C0	ONT)			
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Para.	Test Items	Requirements	Procedures
3.5.21	Cleaning liquid	Sequence Test Group	Unmated card.
	resistance	6	Isopropyl alcohol; 5minutes.
			Without rubbing.
			In acc. with IEC 60068-2-45
3.5.22	Industrial atmosphere	Sequence Test Group	SO2; 100ppb / NO2; 200ppb
		2	H2S; 10 ppb / Cl2; 10ppb
			30° C, 70° Humidity; 10 days.
			Sample1~2; Unmated
			Sample3~4; Mated Au-plated
			dummy card
			Sample5~6; Mated real card
			In acc. with EIA364-65A CLASS I
			Α

Fig. 1 (End)

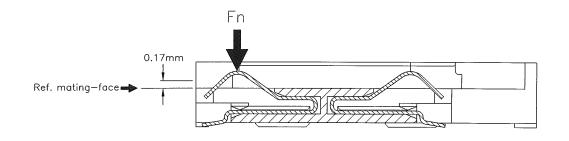
- 3.6 Additional Testing Details
- 3.6.1 Terminal Resistance



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3.6.2

The actual Phone Hand-sets shall be used for Mechanical Operation, Vibration and Physical Shock tests or else test frame(s) shall simulate the actual application as indicated in figures 3(slide insertion).





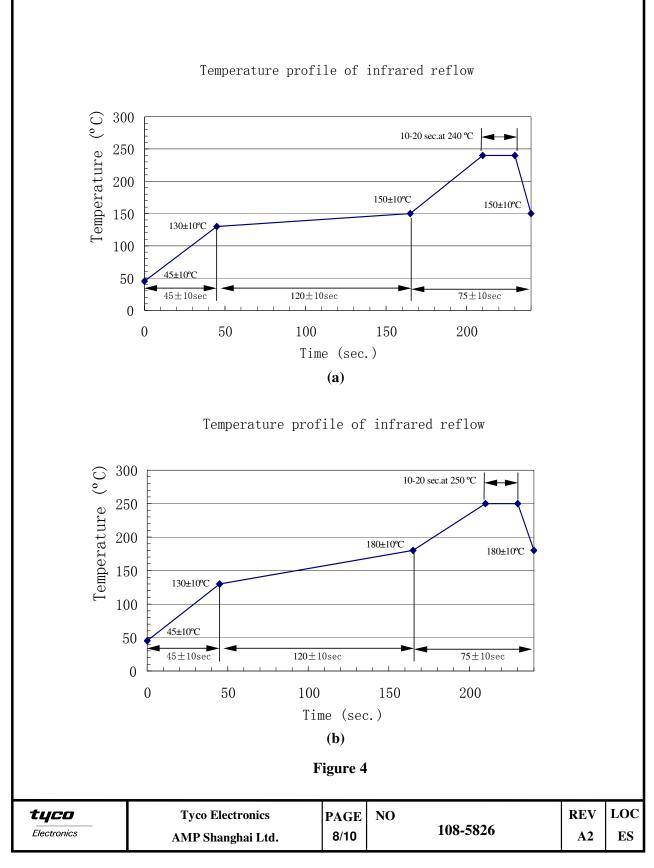
3.6.3 IR Reflow Profile

Resistance to soldering heat test samples shall be placed on a bare surface of a Printed Circuit Board.Test heat-curve shall cover the IR/Convection solder reflow conditions as indicated in table 1.All temperatures refer to the topside of the package as measured on the PC-board surface. Between exposures, parts shall be allowed to cool down to room temperature, for 5 minutes minimum.

Product Part No.	Test heat-curve	
1612586-1	Follow Figure 4 (a)	
292123-1	Follow Figure 4 (a)	
292405-1	Follow Figure 4 (b)	
6612586-1	Follow Figure 4 (b)	

Table 1

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4. Product Qualification Test Sequence

	Test Group								
Test Items	1	2	3	4	5	6			
	Test Sequence (a)								
Examination of Product	1,3,11,16,26	1,4,7,11	1,12	1,3	1,3	1,9			
Termination Resistance	5,14,24	2,5,8,10	2,8			2,6			
Insulation Resistance	6,13,22		3,10			3,7			
Voltage Proof	7,15,23		4,11			4,8			
Electrical load & temperature			6						
Current cycling capacity				2					
Contact normal force	4,25		5,9						
Vibration Sinusoidal	8								
Mechanical Operation 1	18								
Mechanical Operation 2	21								
Mechanical Operation 3		3,9							
Physical Shock 1	9								
Physical Shock 2	10								
Rapid change of temperature	12								
Dry Heat 1	17								
Dry Heat 2			7						
Damp / heat steady state	19								
Cold	20								
Solder ability					2				
Resistance to Soldering Heat	2								
Cleaning liquid resistance						5			
Industrial atmosphere		6							

(a) Numbers indicate sequence in which the tests are performed.

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Product Part No.	Description
1(1050(1	SIM READER SLIDE TYPE
1612586-1	ASSY 6P H=2.9
202122.1	SIM READER SLIDE TYPE WITH SOLDER PRGS
292123-1	ASSY 6P H=3.2mm
292405-1	SIM READER SLIDE TYPE FOR SPECIAL LAYOUT
	ASSY 6P H=3.2mm
	SIM READER SLIDE TYPE
6612586-1	ASSY 6P H=2.9mm

The applicable product descriptions and part numbers are as shown in Appendix. 1.

Appendix 1

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